

Notice of References Cited	Application/Control No. 10/026,522	Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner David A. Zarneke	Art Unit 2827	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,548,152	04-2003	Nakatani et al.	428/209
*	C	US-6,522,555	02-2003	Hirano et al.	361/760
*	D	US-6,329,045	12-2001	Hirano et al.	428/209
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	US Application Serial Number 10/313,534, Nakatani et al.
*	V	US Application Serial Number 09/956,208, Hirano et al.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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